U.S. PATENT DOCUMENTS

Exam. Initial	Document Number	Date	Name	Class	Sub Class	Filing Date
PAU	6,109,104	8/29/2000	Fukuda et al.	73	504.13	
MD AK	5,912,524	6/15/1999	Ohnishi et al.	310	321	
MMAL	6,049,158	4/11/2000	Takeuchi et al.	310	328	
mn AM	6,140,739	10/31/2000	Arai et al.	310	321	
my AN	5,969,248	10/19/1999	Kurachi et al.	73	504.1	2

FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	Class	Sub Class	Translation	Abstract

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages Etc.)

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Examiner	Thomas M. Dovaherty	Date Considered //~/30-0/0083 01
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